

<b>Search Notes</b> 	<b>Application/Control No.</b>  10/601,922	<b>Applicant(s)/Patent under Reexamination</b>  CHEN ET AL.
	<b>Examiner</b>  Jason L. Lazorcik	<b>Art Unit</b>  1791

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Inventor Search	10/23/2006	JLL
Class Search (Key Word Limited)	10/23/2006	JLL
EAST Search (See Search History)	10/23/2006	JLL
Updated EAST Search	4/12/2007	JLL
Updated Search	11/20/2007	JLL